SECTION 4

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FAULT DIAGNOSIS AND REPAIR

Sub-Section

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1. INTRODUCTION

1.1 Test Equipment

1.1.1 Section 4 is intended as a guide to fault diagnosis and repair. It is written for repair staff who are familiar with standard fault-finding procedures and who have the requisite test equipment available. The table below lists the minimum required test equipment and materials.

EQUIPMENT	SPECIFICATION/ MANUFACTURER
Frequency Meter	General Purpose
Oscilloscope	Rise time 100 nanosec
Digital Multimetert	General purpose
Known good LED display unit	Cambridge Computer
Known good keyboard unit	Cambridge Computer
Mains Adaptor	Cambridge Computer
Superglue	Open market

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